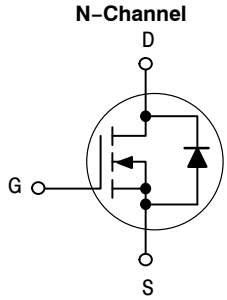
N-Channel Enhancement Mode Field Effect Transistor

2N7002L

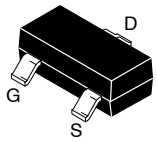


Description

This N−channel enhancement mode field effect transistor is produced using high cell density, trench MOSFET technology. This product minimizes on−state resistance while providing rugged, reliable and fast switching performance. This product is particularly suited for low−voltage, low−current applications such as small servo motor control, power MOSFET gate drivers, logic level translator, high speed line drivers, power management/power supply, and switching applications.

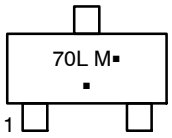
Features

- High Density Cell Design for Low $R_{DS(ON)}$
- Voltage Controlled Small Signal Switch
- Rugged and Reliable
- High Saturation Current Capability
- Very Low Capacitance
- Fast Switching Speed
- This Device is Pb−Free and Halogen Free



SOT−23
CASE 318−08

MARKING DIAGRAM



70L = Device Code
M = Date Code*
▪ = Pb−Free Package
(Note: Microdot may be in either location)
*Date Code orientation and/or position may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping†
2N7002L	SOT−23 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain−Source Voltage	60	V
V_{DGR}	Drain−Gate Voltage ($R_{GS} \leq 1.0$ MΩ)	60	V
V_{GSS}	Gate−Source Voltage − Continuous − Non Repetitive (t_p < 50 μs)	 ±20 ±40	V
I_D	Maximum Drain Current − Continuous − Pulsed	 115 800	mA
T_J, T_{STG}	Operating and Storage Temperature Range	−55 to +150	°C
T_L	Maximum Lead Temperature for Soldering Purposes, 1/16″ from Case for 10 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted) (Note 1)

Symbol	Parameter	Value	Unit
P_D	Maximum Power Dissipation	200	mW
	Derate Above 25°C	1.6	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction−to−Ambient	380	°C/W

ESD RATING (Note 2)

Symbol	Parameter	Value	Unit
HBM	Human Body Model per ANSI/ESDA/JEDEC JS−001−2012	50	V
CDM	Charged Device Model per JEDEC C101C	>2000	V

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV_{DSS}	Drain−Source Breakdown Voltage	V_{GS} = 0 V, I_D = 10 μA	60.0	65.2	–	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 60 V, V_{GS} = 0 V	–	0.024	1	μA
		V_{DS} = 60 V, V_{GS} = 0 V, T_J = 125°C	–	0.080	500	
I_{GSSF}	Gate−Body Leakage, Forward	V_{GS} = 20 V, V_{DS} = 0 V	–	0.107	100	nA
I_{GSSR}	Gate−Body Leakage, Reverse	V_{GS} = −20 V, V_{DS} = 0 V	–	−0.037	−100	nA
ON CHARACTERISTICS (Note 3)						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA	0.80	1.81	2.50	V
$R_{DS(on)}$	Static Drain−Source On−Resistance	V_{GS} = 10 V, I_D = 500 mA	–	3.35	7.50	Ω
		V_{GS} = 10 V, I_D = 500 mA, T_J = 100°C	–	5.62	13.50	
		V_{GS} = 5 V, I_D = 50 mA	–	2.68	7.50	
		V_{GS} = 5 V, I_D = 50 mA, T_J = 100°C	–	3.97	13.50	
$V_{DS(ON)}$	Drain−Source On−Voltage	V_{GS} = 10 V, I_D = 500 mA	–	1.68	3.75	V
		V_{GS} = 5 V, I_D = 50 mA	–	0.13	1.50	
$I_{D(ON)}$	On−State Drain Current	V_{GS} = 10 V, $V_{DS} \geq 2\ V_{DS(ON)}$	500	557	–	mA
		V_{GS} = 4.5 V, V_{DS} = 10 V	75	571	–	

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
ON CHARACTERISTICS (Note 3)						
g_{FS}	Forward Trans−conductance	$V_{DS} \geq 2\ V_{DS(ON)}$, I_D = 200 mA	80	214	–	mS
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	–	12.8	50	pF
C_{oss}	Output Capacitance		–	3.25	25	
C_{rss}	Reverse Transfer Capacitance		–	1.52	5	
R_G	Gate Resistance	V_{GS} = 0 V, f = 1.0 MHz	–	22.2	–	Ω
SWITCHING CHARACTERISTICS (Note 3)						
t_{on}	Turn−On Time	V_{DD} = 30 V, R_L = 150 Ω, I_D = 200 mA, V_{GS} = 10 V, R_{GEN} = 25 Ω	–	4.35	20	ns
t_{off}	Turn−Off Time		–	15.6	20	ns
DRAIN−SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
I_S	Maximum Continuous Drain−Source Diode Forward Current		–	–	115	mA
I_{SM}	Maximum Pulsed Drain−Source Diode Forward Current		–	–	0.8	A
V_{SD}	Drain−Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 115 mA (Note 3)	–	0.818	1.5	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is the sum of the junction−to−case and case−to−ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a) 380°C/W when mounted on a minimum pad.

2. ESD values are in typical, no over−voltage rating is implied, ESD CDM zap voltage is 2000 V maximum.
3. Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2.0%.

TYPICAL CHARACTERISTICS

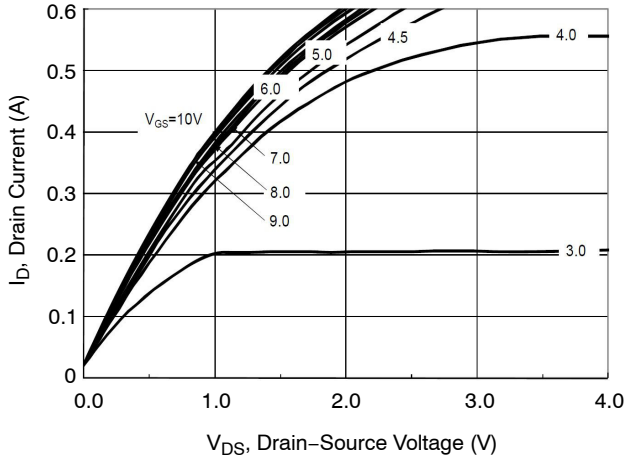

Figure 1. On−Region Characteristics

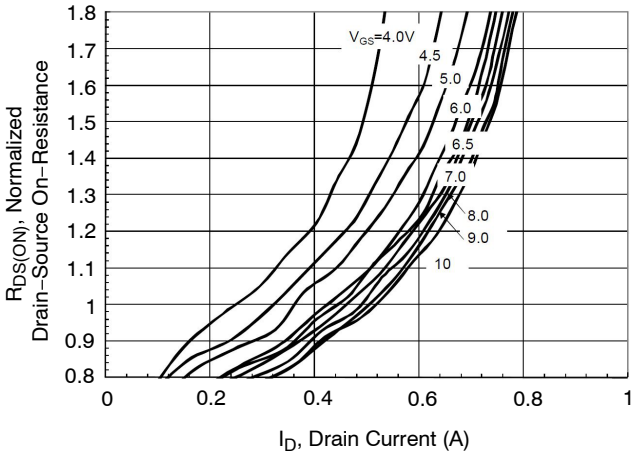

Figure 2. On−Resistance Variation with Gate Voltage and Drain Current

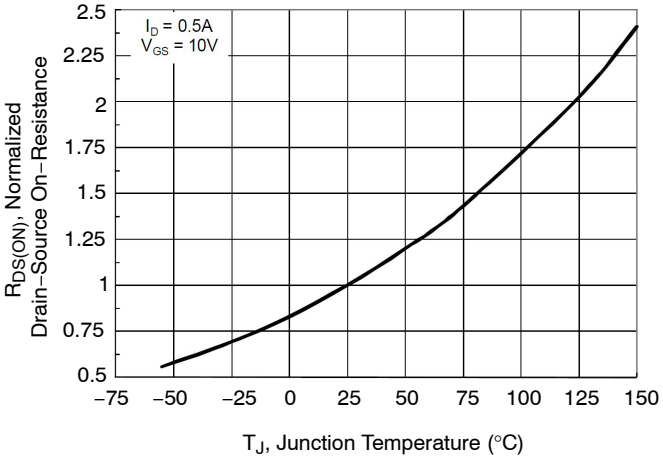

Figure 3. On−Resistance Variation with Temperature

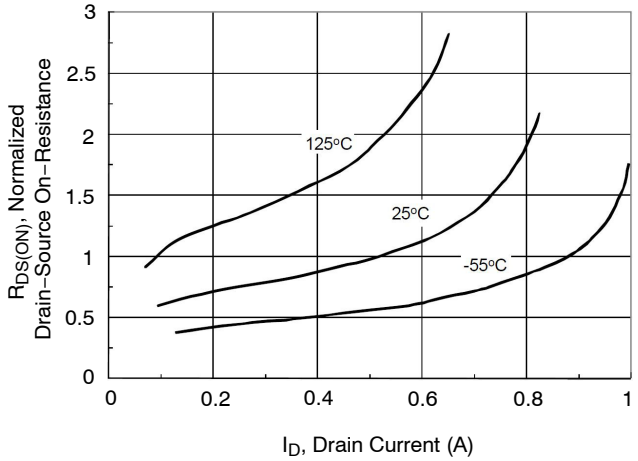

Figure 4. On−Resistance Variation with Drain Current and Temperature

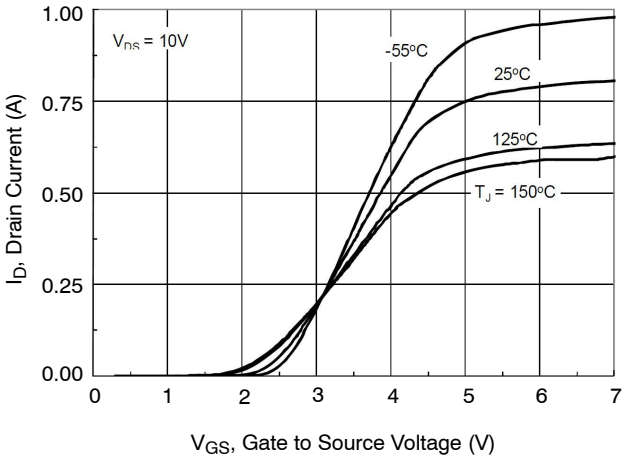

Figure 5. Transfer Characteristics

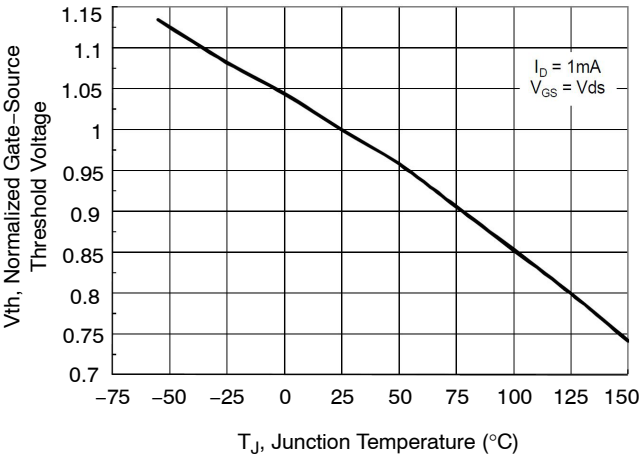

Figure 6. Gate Threshold Variation with Temperature

TYPICAL CHARACTERISTICS (continued)

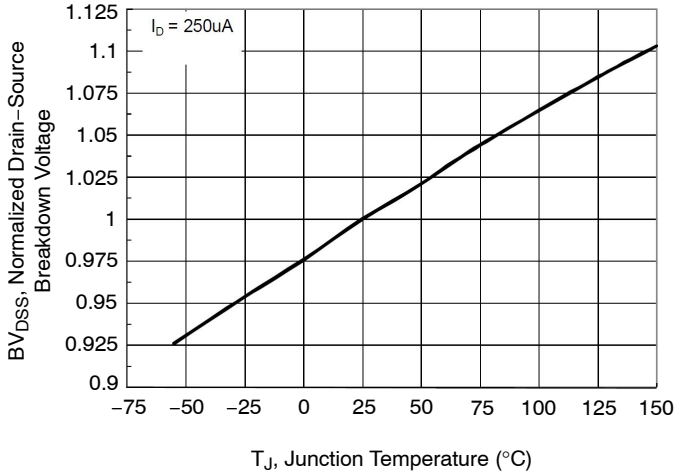

Figure 7. Breakdown Voltage Variation with Temperature

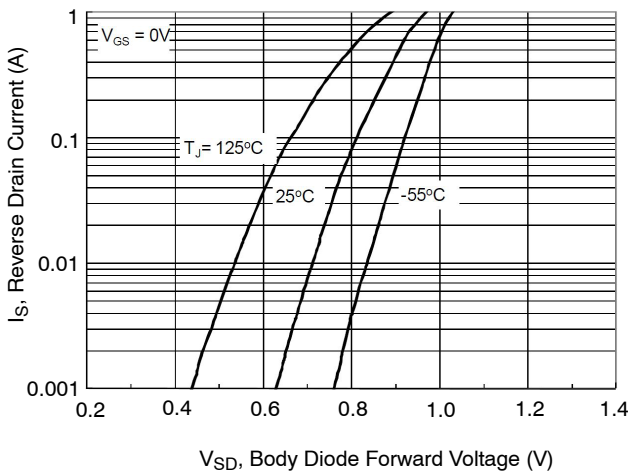

Figure 8. Body Diode Forward Voltage Variation with Source Current and Temperature

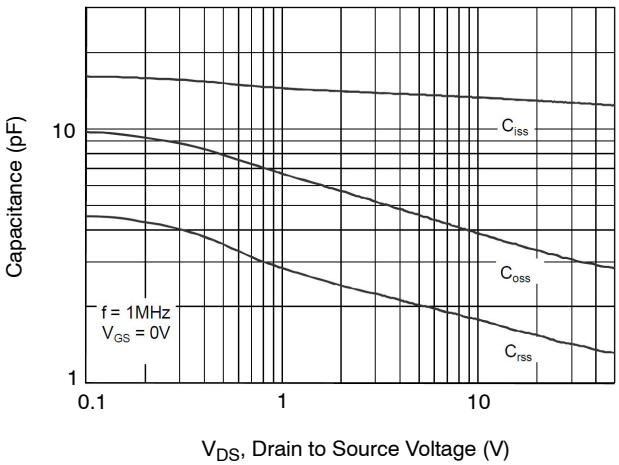

Figure 9. Capacitance Characteristics

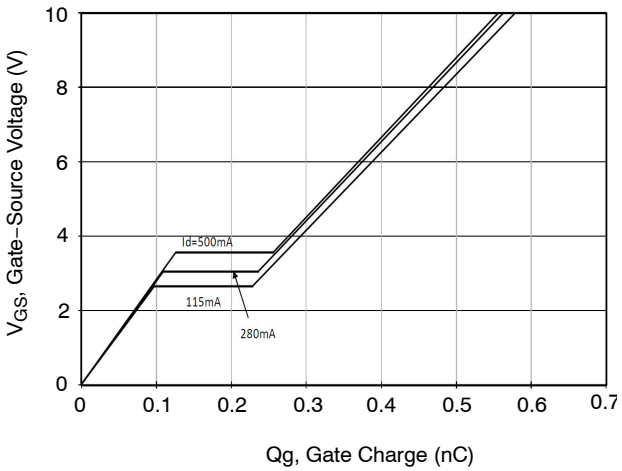

Figure 10. Gate Charge Characteristics

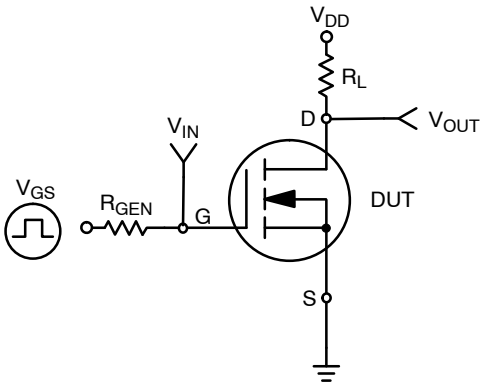

Figure 11.

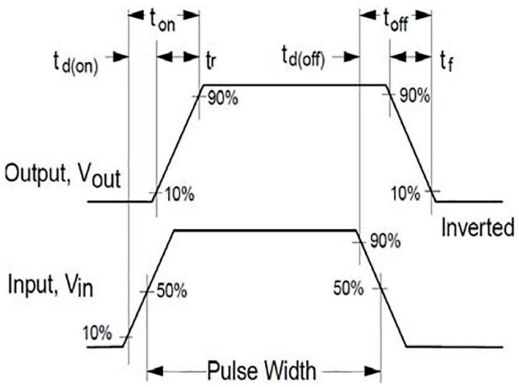

Figure 12. Switching Waveforms

TYPICAL CHARACTERISTICS (continued)

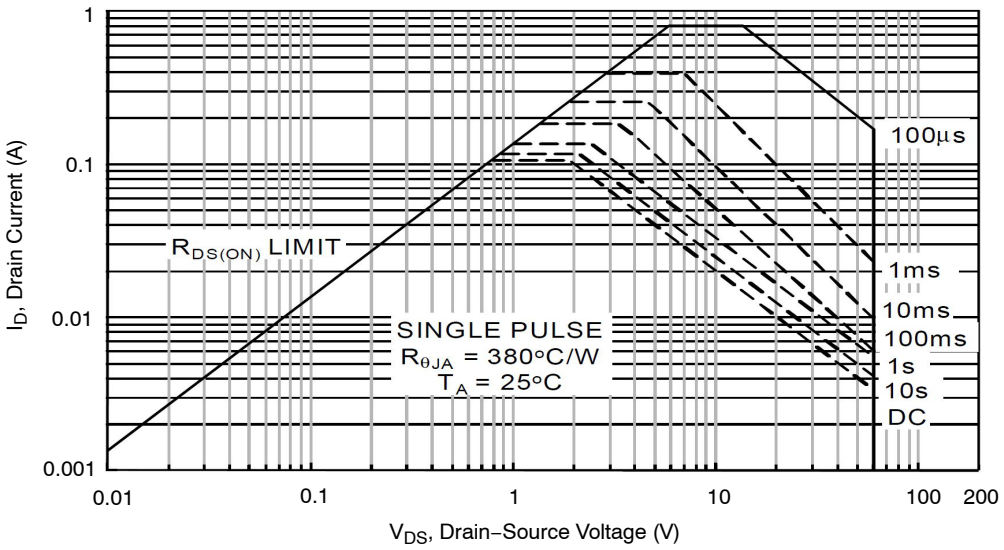

Figure 13. Maximum Safe Operating Area

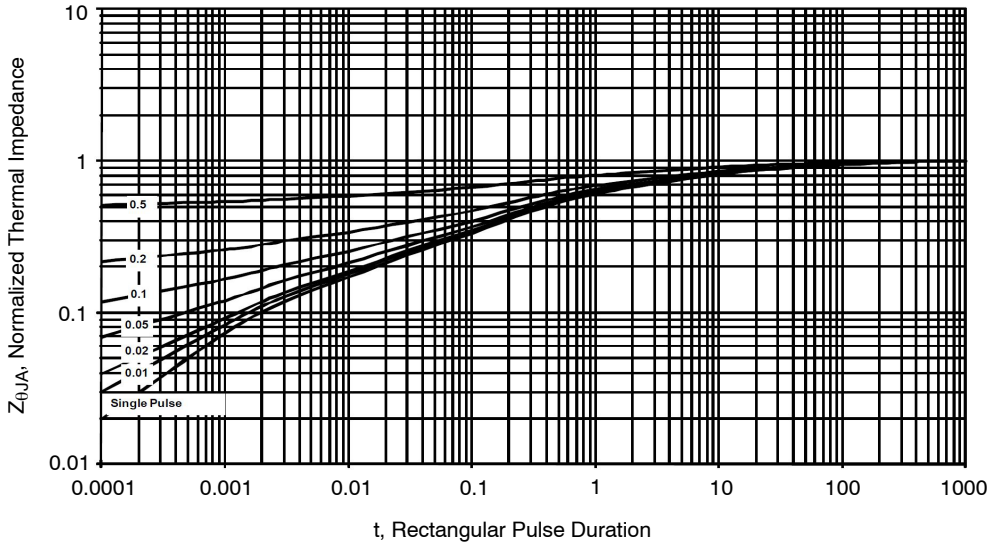

Figure 14. Transient Thermal Response Curve

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